INTEGRATED CIRCUITS



Product specification

1996 Jan 05

IC15 Data Handbook





74F169

FEATURES

- Synchronous counting and loading
- Up/Down counting
- Modulo 16 binary counter
- Two Count Enable inputs for n-bit cascading
- Positive edge-triggered clock
- Built-in carry look-ahead capability
- Presettable for programmable operation

DESCRIPTION

The 74F169 is a 4-bit synchronous, presettable Modulo 16 up/down counter featuring an internal carry look-ahead for applications in high-speed counting designs. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when instructed by the Count Enable inputs and internal gating. This mode of operation eliminates the output spikes which are normally associated with asynchronous (ripple clock) counters. A buffered clock input triggers the flip-flops on the Low-to-High transition of the clock.

The counter is fully programmable; that is, the outputs may be preset to either level.

Presetting is synchronous with the clock and takes place regardless of the levels of the Count Enable inputs. A Low level on the Parallel Enable (PE) input disables the counter and causes the data at the D_n input to be loaded into the counter on the next Low-to-High transition of the clock.

The direction of counting is controlled by the Up/Down (U/\overline{D}) input; a High will cause the count to increase, a Low will cause the count to decrease.

The carry look-ahead circuitry provides for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two Count Enable inputs (\overline{CET} , \overline{CEP}) and a Terminal Count (\overline{TC}) output. Both Count Enable inputs must be Low to count. The \overline{CET} input is fed forward to enable the \overline{TC} output. The \overline{TC} output thus enabled will produce a Low output pulse with a duration approximately equal to the High level portion of the Q₀ output. The Low level \overline{TC} pulse is used to enable successive cascaded stages.

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F(U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
D ₀ - D ₃	Parallel data inputs	1.0/1.0	20µA/0.6mA
CEP	Count Enable parallel input (active Low)	1.0/1.0	20µA/0.6mA
CET	Count Enable Trickle input (active Low)	1.0/2.0	20µA/1.2mA
СР	Clock input (active rising edge)	1.0/1.0	20µA/0.6mA
PE	Parallel Enable input (active Low)	1.0/1.0	20µA/0.6mA
U/D	Up/Down count control input	1.0/1.0	20µA/0.6mA
Q ₀ - Q ₃	Flip-flop outputs	50/33	1.0mA/20mA
TC	Terminal count output (active Low)	50/33	1.0mA/20mA

NOTE: One (1.0) FAST Unit Load (U.L.) is defined as: 20µA in the High state and 0.6mA in the Low state.

PIN CONFIGURATION



TYPE	TYPICAL f _{MAX}	TYPICAL SUPPLY CURRENT (TOTAL)
74F169	115MHz	35mA

ORDERING INFORMATION

	ORDER CODE			
DESCRIPTION	COMMERCIAL RANGE V _{CC} = 5V ±10%, T _{amb} = 0°C to +70°C	PKG DWG #		
16-pin plastic DIP	N74F169N	SOT38-4		
16-pin plastic SO	N74F169D	SOT109-1		

74F169



FUNCTIONAL DESCRIPTION

c = Pin 16

GND = Pin 8

The 74F169 uses edge-triggered J-K-type flip-flops and have no constraints on changing the control or data input signals in either state of the clock. The only requirement is that the various inputs attain the desired state at least a setup time before the rising edge of the clock and remain valid for the recommended hold time thereafter. The parallel load operation takes precedence over the other operations, as indicated in the Mode Select Table. When PE is Low, the data on the D₀ - D₃ inputs enter the flip-flops on the next rising edge of the Clock. In order for counting to occur, both \overline{CEP} and \overline{CET} must be Low and PE must be High; the U/D input determines the direction of counting. The Terminal Count (TC) output is normally High and goes Low, provided that \overline{CET} is Low,

LOGIC SYMBOL (IEEE/IEC)



when a counter reaches zero in the Count Down mode or reaches 15 in the Count Up mode. The \overline{TC} output state is not a function of the Count Enable Parallel (\overline{CEP}) input level. Since the \overline{TC} signal is derived by decoding the flip-flop states, there exists the possibility of decoding spikes on \overline{TC} . For this reason the use of \overline{TC} as a clock signal is not recommended (see logic equations below).

1) Count Enable = $\overline{CEP} \cdot \overline{CET} \cdot \overline{PE}$

2) Up: $\overline{\text{TC}} = \text{Q}_0 \cdot \text{Q}_3 \cdot (\text{U/D}) \cdot \overline{\text{CET}}$

3) Down: $\overline{\text{TC}} = Q_0 \cdot Q_1 \cdot Q_2 \cdot Q_3 \cdot (U/\overline{D}) \cdot \overline{\text{CET}}$

	_	INP	UTS	-		OUTPUT	S	
СР	U/D	CEP	CET	PE	D _n	Q _n	TC	OPERATING MODE
↑	Х	Х	Х	I	I	L	(1)	Parallel load (Dn→Qn)
↑	Х	Х	Х	Х	Х	Н	(1)	
↑	h	I	I	h	Х	Count Up	(1)	Count Up (increment)
↑	I	I	I	h	Х	Count Down	(1)	Count Down (decrement)
↑ (Х	h	Х	h	Х	q _n	(1)	Hold (do nothing)
↑	Х	Х	Х	h	Х	q _n	н	

MODE SELECT — FUNCTION TABLE

H = High voltage level steady state

h = High voltage level one setup time prior to the Low-to-High clock transition

L = Low voltage level steady state

I = Low voltage level one setup time prior to the Low-to-High clock transition

q = Lower case letters indicate the state of the referenced output prior to the Low-to-High clock transition

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X = Don't care

 \uparrow = Low-to-High clock transition

(1) = The \overline{TC} is Low when \overline{CET} is Low and the counter is at Terminal Count.

Terminal Count Up is (HHHH) and Terminal Count Down is (LLLL).

74F169

4-bit up/down binary synchronous counter

MODE SELECT TABLE

	INP	UTS						
PE	CEP	CET	U/D	OPERATING MODE				
L	Х	Х	Х	Load $(D_n \rightarrow Q_n)$				
н	L	L	н	Count Up (Increment)				
н	L	L	L	Count Down (Decrement)				
н	н	Х	Х	No Change (Hold)				
н	Х	Н	Х	No Change (Hold)				
H = H L = L X = C	ligh Volta .ow Volta .on't care	ge ge Level	_					

STATE DIAGRAM



LOGIC DIAGRAM



74F169



APPLICATION

Figure 1. Synchronous Multistage Counting Scheme

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	-0.5 to +V _{CC}	V
I _{OUT}	Current applied to output in Low output state	40	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{STG}	Storage temperature	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER		LIMITS				
		Min	Nom	Max			
V _{CC}	Supply voltage	4.5	5.0	5.5	V		
V _{IH}	High-level input voltage	2.0			V		
VIL	Low-level input voltage			0.8	V		
I _{IK}	Input clamp current			-18	mA		
I _{OH}	High-level output current			-1	mA		
I _{OL}	Low-level output current			20	mA		
T _{amb}	Operating free-air temperature range	0		70	°C		

74F169

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

						LIMITS		UNIT
SYMBOL	PARAMETE	R	TEST CONDITIONS ^{NO TAG}	MIN	TYP NO TAG	МАХ		
Maria			V _{CC} = MIN, V _{IL} = MAX,	$\pm 10\% V_{CC}$	2.5			V
		V _{IH} = MIN, I _{OH} = MAX	±5%V _{CC}	2.7	3.4		V	
Max			V _{CC} = MIN, V _{IL} = MAX,	$\pm 10\% V_{CC}$		0.35	0.50	V
VOL Low-level output voltage			$V_{IH} = MIN, I_{OL} = MAX$	±5%V _{CC}		0.35	0.50	V
V _{IK}	Input clamp voltage		$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.2	V
lı	Input current at maximun voltage	n input	$V_{CC} = MAX, V_I = 7.0V$				100	μΑ
I _{IH}	High-level input current	_	$V_{CC} = MAX, V_1 = 2.7V$				20	μΑ
l.	Low lovel input current	CET	$V_{CC} = MAX, V_I = 0.5V$				-1.2	mA
١L	Low-level input current	Others	$V_{CC} = MAX, V_I = 0.5V$				-0.6	mA
I _{OS}	Short-circuit output curre	nt ^{NO TAG}	V _{CC} = MAX				-150	mA
I _{CC}	Supply current (total) ⁴		V _{CC} = MAX			35	52	mA

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

 For conditions shown as wink of MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

4. I_{CC} is measured after applying a momentary 4.5V, then ground to the clock input with all other inputs grounded and all outputs open.

74F169

AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS	Т _а С _L = 5	amb = +25° V _{CC} = +5\ 50pF, R _L =	°C / 500Ω	T _{amb} = 0°C V _{CC} = +5 C _L = 50pF,	UNIT	
			MIN	TYP	MAX	MIN	MAX	
f _{MAX}	Maximum clock frequency	Waveform 1	100	115		90		MHz
t _{PLH}	Propagation delay	Waveform 1	3.0	6.5	8.5	3.0	9.5	ns
t _{PHL}	CP to Q _n (PE, High or Low)		4.0	9.0	11.5	4.0	13.0	ns
t _{PLH}	Propagation delay	Waveform 1	5.5	12.0	15.5	5.5	17.0	ns
t _{PHL}	CP to TC		4.0	8.5	11.0	4.0	12.5	ns
t _{PLH}	Propagation delay	Waveform 2	2.5	4.5	6.0	2.5	7.0	ns
t _{PHL}	CET to TC		2.5	6.0	8.0	2.5	9.0	ns
t _{PLH}	Propagation delay	Waveform 3	3.5	8.5	15.0	3.5	15.5	ns
t _{PHL}	U/D to TC		4.0	8.0	10.5	4.0	12.0	ns

AC SETUP REQUIREMENTS

			LIM	IITS	LIM	ITS		
SYMBOL	PARAMETER	TEST CONDITIONS	T _{amb} = V _{CC} = C _L = 50pF,	+25°C +5.0V R _L = 500Ω	T _{amb} = 0°C V _{CC} = +5. C _L = 50pF,	UNIT		
			MIN	TYP	MIN	MAX		
t _s (H) t _s (L)	Setup time, High or Low D_n to CP	Waveform 4	4.0 4.0		4.5 4.5		ns ns	
t _h (H) t _h (L)	Hold time, High or Low D _n to CP	Waveform 4	3.0 3.0		3.5 3.5		ns ns	
t _s (H) t _s (L)	Set-up time, High or Low CEP or CET to CP	Waveform 5	5.0 5.0		5.5 5.5		ns ns	
t _h (H) t _h (L)	Hold time, High or Low CEP or CET to CP	Waveform 5	0 0		0 0		ns ns	
t _s (H) t _s (L)	Set-up time, High or Low PE to CP	Waveform 4	8.0 8.0		9.0 9.0		ns ns	
t _h (H) t _h (L)	Hold time, High or Low PE to CP	Waveform 4	0 0		0 0		ns ns	
t _s (H) t _s (L)	Set-up time, High or Low U/\overline{D} to CP	Waveform 6	11.0 7.0		12.5 8.0		ns ns	
t _h (H) t _h (L)	Hold time, High or Low U/D to CP	Waveform 6	0 0		0 0		ns ns	
t _w (H) t _w (L)	CP _U or CP _D pulse width, High or Low	Waveform 1	5.0 5.0		5.5 5.5		ns ns	

AC WAVEFORMS

For all waveforms, $V_M = 1.5V$

The shaded areas indicate when the input is permitted to change for predictable output performance.



Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency



Waveform 3. Propagation Delay U/D Input to Terminal Count Output



Waveform 5. Count Enable Setup and Hold Times



Waveform 2. Propagation Delays CET Input to Terminal Count Output



Waveform 4. Parallel Data and Parallel Enable Setup and Hold Times



Waveform 6. Up/Down Control Setup and Hold Times

74F169





NOTES:

The operation of the 74F169 is similar to the Illustration above.

- 1. Load (preset) to BCD seven
- 2. Count up to eight, nine (maximum), zero, one, and two
- 3. Inhibit
- 4. Count down to one, zero (minimum), nine, eight, and seven

TEST CIRCUIT AND WAVEFORM







UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	b ₂	с	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	M _E	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION		REFEF	EUROPEAN		
	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT38-4					-92-11-17 95-01-14

* Discontinued part. Please see the Discontinued Product List in Section 1, page 21.

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Product specification

SOT38-4

Philips Semiconductors

SO16: plastic small outline package; 16 leads; body width 3.9 mm



74F168*, 74F169

Product specification

SOT109-1

ISSUE DATE

95-01-23

97-05-22

PROJECTION

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IEC

076E07S

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MS-012AC

VERSION

SOT109-1

EIAJ

74F168*, 74F169

DEFINITIONS		
Data Sheet Identification	Product Status	Definition
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.
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